FAIRCHILD SEMICONDUCTOR™

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CD4007C
Dual Complementary Pair Plus Inverter

General Description

The CD4007C consists of three complementary pairs of N- and P-channel enhancement mode MOS transistors suitable for series/shunt applications. All inputs are protected from static discharge by diode clamps to V_{DD} and V_{SS}.

For proper operation the voltages at all pins must be constrained to be between V_{SS} − 0.3V and V_{DD} + 0.3V at all times.

Features

- Wide supply voltage range: 3.0V to 15V
- High noise immunity: 0.45 V_{CC} (typ.)

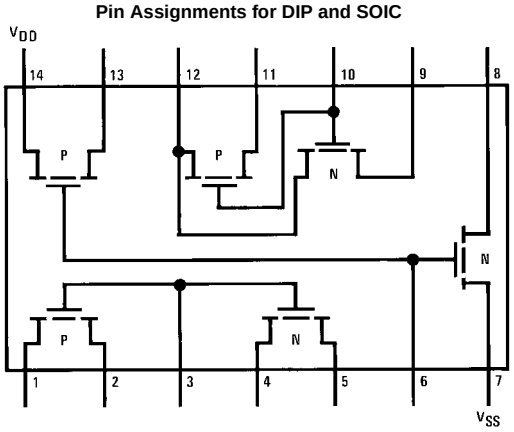
Ordering Code:

Order Number	Package Number	Package Description
CD4007CM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow
CD4007CN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS–001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram

Pin Assignments for DIP and SOIC



Note: All P-channel substrates are connected to V_{DD} and all N-channel substrates are connected to V_{SS}.

Top View

Absolute Maximum Ratings (Note 1)

Voltage at Any Pin	V_{SS} −0.3V to V_{DD} +0.3V
Operating Temperature Range	−40°C to +85°C
Storage Temperature Range	−65°C to +150°C
Power Dissipation (P_D)	
Dual-In-Line	700 mW
Small Outline	500 mW
Operating V_{DD} Range	V_{SS} +3.0V to V_{SS} +15V
Lead Temperature	
(Soldering, 10 seconds)	260°C

Note 1: This device should not be connected to circuits with the power on because high transient voltages may cause permanent damage.

DC Electrical Characteristics

Symbol	Parameter	Conditions	Limits									Units
			−40°C			+25°C			+85°C			
			Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
I_L	Quiescent Device	V_{DD} = 5.0V			0.5		0.005	0.05			15	µA
	Current	V_{DD} = 10V			1.0		0.005	1.0			30	µA
P_D	Quiescent Device	V_{DD} = 5.0V			2.5		0.025	2.5			75	µW
	Dissipation Package	V_{DD} = 10V			10		0.05	10			300	µW
V_{OL}	Output Voltage	V_{DD} = 5.0V			0.05		0	0.01			0.05	V
	LOW Level	V_{DD} = 10V			0.05		0	0.01			0.05	V
V_{OH}	Output Voltage	V_{DD} = 5.0V	4.95			4.95	5.0		4.95			V
	HIGH Level	V_{DD} = 10V	9.95			9.95	10		9.95			V
V_{NL}	Noise Immunity	V_{DD} = 5.0V, V_O = 3.6V			1.5		2.25	1.5			1.4	V
	(All inputs)	V_{DD} = 10V, V_O = 7.2V			3.0		4.5	3.0			2.9	V
V_{NH}	Noise Immunity	V_{DD} = 5.0V, V_O = 0.95V	3.6			3.5	2.25		3.5			V
	(All Inputs)	V_{DD} = 10V, V_O = 2.9V	7.1			7.0	4.5		7.0			V
I_DN	Output Drive Current	V_{DD} = 5.0V, V_O = 0.4V, V_I = V_{DD}	0.35			0.3	1.0		0.24			mA
	N-Channel	V_{DD} = 10V, V_O = 0.5V, V_I = V_{DD}	1.2			1.0	2.5		0.8			mA
I_DP	Output Drive Current	V_{DD} = 5.0V, V_O = 2.5V, V_I = V_{SS}	−1.3			−1.1	−4.0		−0.9			mA
	P-Channel	V_{DD} = 10V, V_O = 9.5V, V_I = V_{SS}	−0.65			−0.55	−2.5		−0.45			mA
I_I	Input Current						10					pA

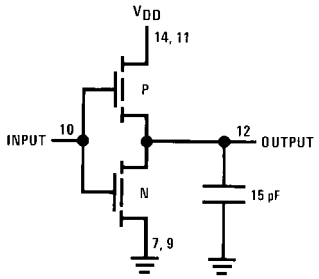
AC Electrical Characteristics (Note 2)

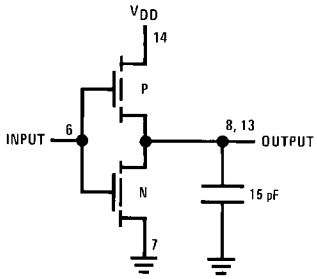
T_A = 25°C and C_L = 15 pF and rise and fall times = 20 ns. Typical temperature coefficient for all values of V_{DD} = 0.3%/°C

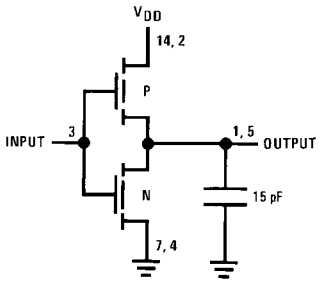
Symbol	Parameter	Conditions	Min	Typ	Max	Units
$t_{PLH} = t_{PHL}$	Propagation Delay Time	V_{DD} = 5.0V		35	75	ns
		V_{DD} = 10V		20	50	ns
$t_{TLH} = t_{THL}$	Transition Time	V_{DD} = 5.0V		50	100	ns
		V_{DD} = 10V		30	50	ns
C_I	Input Capacitance	Any Input		5		pF

Note 2: AC Parameters are guaranteed by DC correlated testing.

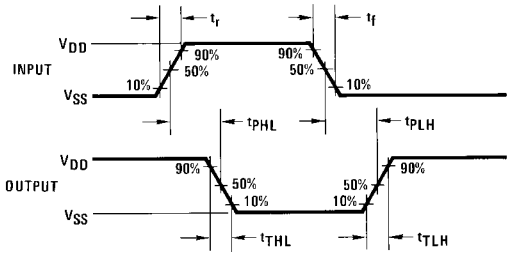
AC Test Circuits



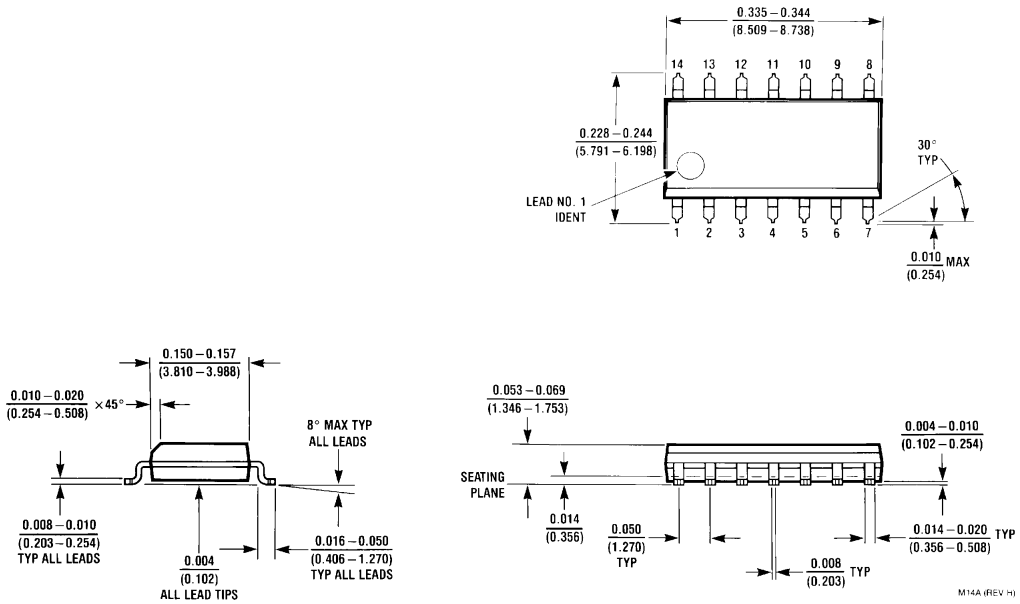




Switching Time Waveforms

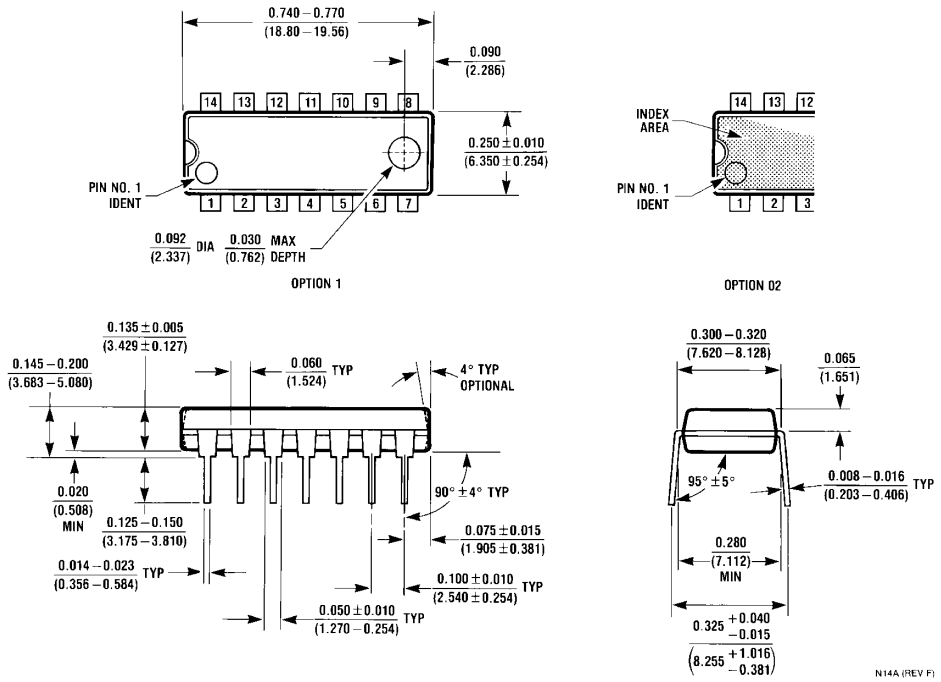


Physical Dimensions inches (millimeters) unless otherwise noted



14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150” Narrow
Package Number M14A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
Package Number N14A

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